

Parkside Laboratories (Aust)

TEST AND CERTIFICATION SERVICES

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Laboratory Test Report

Report No.:

1272/1

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Date Issued:

12 December 2003

SUBJECT:

Cubic switchboard assembly "Cubic Test Panel 2" with various

module types, sizes and protecting devices. For details of module

types, sizes and protecting devices refer herein. 415V 50Hz.

REQUESTED BY:

CUBIC Modulsystem A/S

SKJOLDBORGSGADE 21,

DK700 BROENDERSLEV,

DENMARK

INSTRUCTIONS:

Standard internal arcing-fault tests with the prospective short-circuit

current of 63kA to APPENDIX "ZD" of AS 3439.1-2002 "Low-voltage switchgear and controlgear assemblies Part 1. Type-tested and partially type-tested assemblies"

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SUMMARY:

The tested modules with associated protecting devices passed the

appropriate tests described herein.

NATA APPROVED SIGNATORY: Antony K. Milovac

PREPARED BY:

Steve Kon Test Engineer

Parkside Laboratories (Aust)

Report No.:
Date Issued:

272/1

12 Dec. 2003

GENERAL

- a As detailed in this report, six modules specified in DESCRIPTION were tested.
- b The results detailed in this report were based on the sample submitted by the manufacturer with order No. 150356.
- c The test samples were subjected to the relevant clauses as stated herein.
- d Power supplies used were mains derived a.c. voltage sources of substantially sinusoidal waveform with a nominal frequency of 50Hz unless otherwise noted.
- e Dates of high current tests are shown on oscillograms.
- f Note: N/R means Not Relevant, N/T means Not Tested, DNC means Did Not Comply, T.O. means Test Object.

WITNESSES:

Lars Poulson

CUBIC

Jorn Jacobsen

CUBIC

Bill Mairs

NHP

Stephen Barker

NHP

TEST SPECIFICATION

AS/NZS 3439.1:2002

Low-voltage switchgear and controlgear assemblies – Part 1: Type-tested and partially type-tested assemblies

DATE OF TEST

The testing was performed from 27th to 30th October 2003.

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